

Notice of References Cited	Application/Control No. 10/591,090		Applicant(s)/Patent Under Reexamination BECHTOLD ET AL.	
	Examiner Yaritza Guadalupe-McCall		Art Unit 2841	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,536,983 A	07-1996	Araki et al.	318/135
*	B	US-5,736,797 A	04-1998	Motohashi et al.	318/119
*	C	US-5,980,211 A	11-1999	Tojo et al.	417/45
*	D	US-6,437,524 B1	08-2002	Dimanstein, Isaac	318/135
*	E	US-2003/0059320 A1	03-2003	Kim et al.	417/411
*	F	US-2003/0218854 A1	11-2003	Dimanstein, Isaac	361/187
*	G	US-2004/0005222 A1	01-2004	Yoshida et al.	417/44.11
*	H	US-7,184,254 B2	02-2007	Dimanstein, Isaac	417/45
*	I	US-2007/0236160 A1	10-2007	Reinschke, Johannes	318/135
*	J	US-2007/0257562 A1	10-2007	Reinschke et al.	310/012
*	K	US-7,372,221 B2	05-2008	Reinschke, Johannes	318/135
*	L	US-2009/0153081 A1	06-2009	Bechtold et al.	318/128
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	I					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.